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## Key indicators

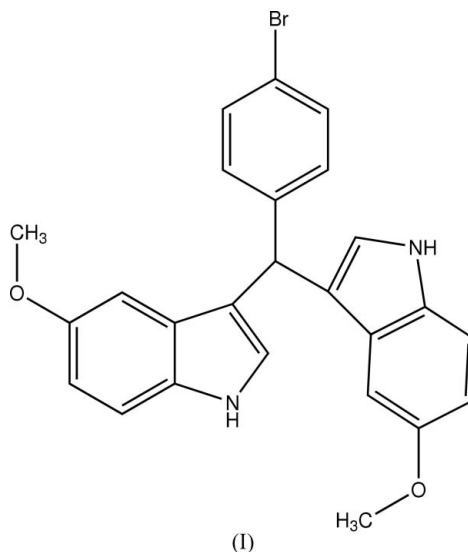
Single-crystal X-ray study  
 $T = 293\text{ K}$   
Mean  $\sigma(\text{C}-\text{C}) = 0.007\text{ \AA}$   
 $R$  factor = 0.058  
 $wR$  factor = 0.135  
Data-to-parameter ratio = 15.4For details of how these key indicators were  
automatically derived from the article, see  
<http://journals.iucr.org/e>.3,3'-(4-Bromophenylmethanediyl)bis(5-  
methoxy-1*H*-indole)

The title compound,  $\text{C}_{25}\text{H}_{21}\text{BrN}_2\text{O}_2$ , was synthesized by the reaction of 5-methoxy-1*H*-indole and 4-bromobenzaldehyde in ethanol, using  $\text{CuBr}_2$  as a catalyst under microwave irradiation. In the crystal structure, there is an intermolecular  $\text{N}-\text{H}\cdots\text{O}$  hydrogen bond and two intermolecular  $\text{C}-\text{H}\cdots\pi$  contacts.

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## Comment

Development of bis(indolyl)alkane synthesis has been of considerable interest because of the wide occurrence of bis(indolyl)alkanes in various natural products possessing biological activity (Bell *et al.*, 1994) and their usefulness for drug design. We report here the crystal structure of the title compound, (I).



The molecular structure of compound (I) is shown in Fig. 1. Bond lengths and angles are within normal ranges (Allen *et al.*, 1987). Ring *A* comprises atoms C20–C25, ring *B* atoms C5/N1/C6/C7/C8 and ring *C* atoms C14/N2/C15/C16/C17. The various dihedral angles are  $A/C = 92.8(2)^\circ$ ,  $B/C = 100.8(1)^\circ$  and  $A/B = 81.6(2)^\circ$ .

The crystal structure of (I) is stabilized by one intermolecular  $\text{N}-\text{H}\cdots\text{O}$  contact and two intermolecular  $\text{C}-\text{H}\cdots\pi$  contacts (Table 1). The  $\text{N}-\text{H}\cdots\text{O}$  hydrogen bond and  $\text{C}-\text{H}\cdots\pi$  contacts are also present in the chloro analogue (Zhang *et al.*, 2006).

## Experimental

Compound (I) was prepared by the reaction of 5-methoxy-1*H*-indole (20 mmol) with 4-bromobenzaldehyde (10 mmol) in ethanol (5 ml),

using CuBr<sub>2</sub> (0.446 g) as catalyst under microwave irradiation (280 W) for 10 min. After completion, the reaction mixture was quenched with H<sub>2</sub>O (10 ml) and extracted with EtOAc (3 × 10 ml). The combined organic layers were dried over Na<sub>2</sub>SO<sub>4</sub>, concentrated, and purified by column chromatography on SiO<sub>2</sub> (ethyl acetate–petroleum ether, 1:3 v/v) to afford the pure product (I). Crystals of (I) suitable for X-ray diffraction were obtained by slow evaporation of a methanol solution.

Crystal data

C<sub>25</sub>H<sub>21</sub>BrN<sub>2</sub>O<sub>2</sub>  
*M<sub>r</sub>* = 461.35  
 Monoclinic, *P*2<sub>1</sub>/*n*  
*a* = 11.227 (2) Å  
*b* = 10.382 (2) Å  
*c* = 18.246 (4) Å  
 β = 90.06 (3)°  
*V* = 2126.7 (7) Å<sup>3</sup>

*Z* = 4  
*D<sub>x</sub>* = 1.441 Mg m<sup>-3</sup>  
 Mo Kα radiation  
 μ = 1.96 mm<sup>-1</sup>  
*T* = 293 (2) K  
 Block, green  
 0.30 × 0.20 × 0.20 mm

Data collection

Enraf–Nonius CAD-4  
 diffractometer  
 ω/2θ scans  
 Absorption correction: ψ scan  
 (North *et al.*, 1968)  
*T<sub>min</sub>* = 0.591, *T<sub>max</sub>* = 0.696  
 4170 measured reflections

4170 independent reflections  
 1986 reflections with *I* > 2σ(*I*)  
 θ<sub>max</sub> = 26.0°  
 3 standard reflections  
 every 200 reflections  
 intensity decay: none

Refinement

Refinement on *F*<sup>2</sup>  
*R* [*F*<sup>2</sup> > 2σ(*F*<sup>2</sup>)] = 0.058  
*wR* (*F*<sup>2</sup>) = 0.135  
*S* = 0.94  
 4170 reflections  
 271 parameters  
 H-atom parameters constrained

*w* = 1/[σ<sup>2</sup>(*F<sub>o</sub>*<sup>2</sup>) + (0.0583*P*)<sup>2</sup>  
 + 0.0001*P*]  
 where *P* = (*F<sub>o</sub>*<sup>2</sup> + 2*F<sub>c</sub>*<sup>2</sup>)/3  
 (Δ/σ)<sub>max</sub> < 0.001  
 Δρ<sub>max</sub> = 0.25 e Å<sup>-3</sup>  
 Δρ<sub>min</sub> = -0.40 e Å<sup>-3</sup>

Table 1

Hydrogen-bond geometry (Å, °).

<i>D</i> –H··· <i>A</i>	<i>D</i> –H	H··· <i>A</i>	<i>D</i> ··· <i>A</i>	<i>D</i> –H··· <i>A</i>
N2–H2A···O1 <sup>i</sup>	0.86	2.35	2.973 (5)	129
C1–H1D···Cg1 <sup>iii</sup>	0.96	2.78	3.646 (3)	126
C24–H24A···Cg2 <sup>iii</sup>	0.93	2.74	3.608 (4)	157

Symmetry codes: (i) *x* + 1, *y*, *z*; (ii)  $-x + \frac{3}{2}, y + \frac{1}{2}, -z + \frac{1}{2}$ ; (iii)  $-x + \frac{1}{2}, y + \frac{1}{2}, -z + \frac{1}{2}$ . Cg1 and Cg2 denote the centroids of the C2–C5/C8/C9 and C14/N2/C15–C17 rings, respectively

All H atoms were placed in idealized positions and refined as riding, with C–H = 0.93–0.98 Å and N–H = 0.86 Å, and with *U<sub>iso</sub>*(H) = *xU<sub>eq</sub>*(parent atom), where *x* = 1.5 for methyl and 1.2 for all other H atoms.

Data collection: *CAD-4 Software* (Enraf–Nonius, 1989); cell refinement: *CAD-4 Software*; data reduction: *XCAD4* (Harms &

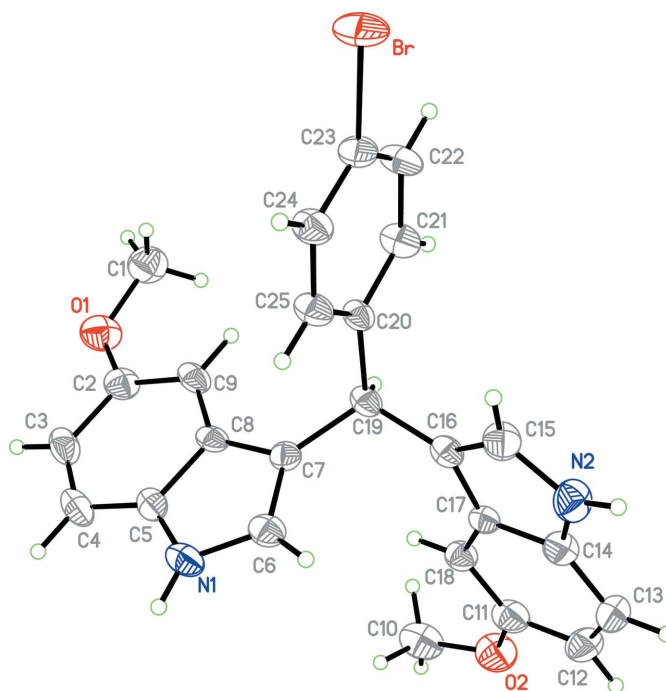


Figure 1

The molecular structure of (I), showing the atom-labelling scheme. Displacement ellipsoids are drawn at the 30% probability level.

Wocadlo, 1995); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *SHELXTL* (Siemens, 1996); software used to prepare material for publication: *SHELXTL*.

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